

100302

Low Power Quint 2-Input OR/NOR Gate

General Description

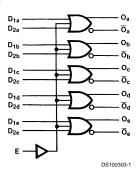
The 100302 is a monolithic quint 2-input OR/NOR gate with common enable. All inputs have 50 k Ω pull-down resistors and all outputs are buffered.

- 2000V ESD protection
- Pin/function compatible with 100102
- Voltage compensated operating range = -4.2V to -5.7V
- Standard Microcircuit Drawing (SMD) 5962-9152802

Features

■ 43% power reduction of the 100102

Logic Symbol



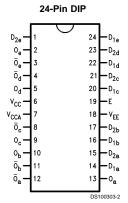
Pin Names	Description
D _{na} -D _{ne}	Data Inputs
E	Enable Input
O _a -O _e	Data Outputs
$\overline{O}_{a}\text{-}\overline{O}_{e}$	Complementary Data Outputs

Truth Table

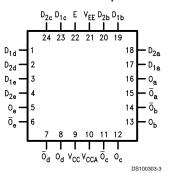
D _{1X}	D _{2X}	E	O _x	\overline{o}_{x}
L	L	L	L	Н
L	L	Н	Н	L
L	Н	L	Н	L
L	Н	Н	Н	L
Н	L	L	Н	L
Н	L	Н	Н	L
Н	Н	L	Н	L
Н	Н	Н	Н	L

H = HIGH Voltage Level L = LOW Voltage Level

Connection Diagrams



24-Pin Quad Cerpak



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Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Above which the useful life may be impaired

Storage Temperature (T_{STG}) $-65^{\circ}C$ to +150 $^{\circ}C$

Maximum Junction Temperature (T_J)

Ceramic +175°C

 ${\rm V}_{\rm EE}$ Pin Potential to

Ground Pin -7.0V to +0.5V

Input Voltage (DC) V_{EE} to +0.5V

Output Current (DC Output HIGH) -50 mA

ESD (Note 2)

≥2000V

Recommended Operating Conditions

Case Temperature (T_C)

Military $-55^{\circ}\text{C} \text{ to } +125^{\circ}\text{C}$

Supply Voltage (V_{EE})

-5.7V to -4.2V

Note 1: Absolute maximum ratings are those values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: ESD testing conforms to MIL-STD-883, Method 3015.

Military Version DC Electrical Characteristics

 V_{EE} = -4.2V to -5.7V, V_{CC} = V_{CCA} = GND, T_{C} = -55°C to +125°C (Note 5)

Symbol	Parameter	Min	Max	Units	T _C	Cond	Conditions	
V _{OH}	Output HIGH Voltage	-1025	-870	mV	0°C to +125°C			
		-1085	-870	mV	−55°C	$V_{IN} = V_{IH(Max)}$	Loading with	(Notes 3, 4,
V _{OL}	Output LOW Voltage	-1830	-1620	mV	0°C to +125°C	or V _{IL} (Min)	50Ω to -2.0V	5)
		-1830	-1555	mV	−55°C			
V _{OHC}	Output HIGH Voltage	-1035		mV	0°C to +125°C			
		-1085		mV	−55°C	$V_{IN} = V_{IH(Max)}$	Loading with	(Notes 3, 4,
V _{OLC}	Output LOW Voltage		-1610	mV	0°C to +125°C	or V _{IL} (Min)	50Ω to -2.0V	5)
			-1555	mV	−55°C			
V _{IH}	Input HIGH Voltage	-1165	-870	mV	–55°C to +125°C	Guaranteed HIGH Signal for All Inputs		(Notes 3, 4,
								5, 6)
V _{IL}	Input LOW Voltage	-1830	-1475	mV	-55°C to +125°C	Guaranteed LOV	V Signal	(Notes 3, 4,
						for All Inputs		5, 6)
I _{IL}	Input LOW Current	0.50		μΑ	-55°C to +125°C	$V_{EE} = -4.2V$		(Notes 3, 4,
						$V_{IN} = V_{IH} (Max)$		5)
I _{IH}	Input HIGH Current		240	μΑ	0°C to +125°C	$V_{EE} = -5.7V$		(Notes 3, 4,
			340	μA	−55°C	$V_{IN} = V_{IL(Min)}$		5)
I _{EE}	Power Supply Current	-48	-17	mA	-55°C to +125°C	Inputs Open		(Notes 3, 4, 5, 6)

Note 3: F100K 300 Series cold temperature testing is performed by temperature soaking (to guarantee junction temperature equals -55°C), then testing immediately without allowing for the junction temperature to stabilize due to heat dissipation after power-up. This provides "cold start" specs which can be considered a worst case condition at cold temperatures.

Note 4: Screen tested 100% on each device at -55°C, +25°C, and +125°C, Subgroups 1, 2, 3, 7, and 8.

Note 5: Sample tested (Method 5005, Table I) on each manufactured lot at -55°C, +25°C, and +125°C, Subgroups A1, 2, 3, 7, and 8.

Note 6: Guaranteed by applying specified input condition and testing V_{OH}/V_{OL}.

AC Electrical Characteristics

 $V_{\rm EE}$ = -4.2V to -5.7V, $V_{\rm CC}$ = $V_{\rm CCA}$ = GND

Symbol	Parameter	T _C = -55°C		T _C = +25°C		T _C = +125°C		Units	Conditions	Notes
		Min	Max	Min	Max	Min	Max			
t _{PLH}	Propagation Delay	0.30	1.80	0.40	1.50	0.40	1.70	ns		(Notes 7, 8,
t _{PHL}	Data to Output									9, 10, 11)
t _{PLH}	Propagation Delay	0.60	2.60	0.80	2.30	0.80	2.80	ns	Figures 1 2	
t _{PHL}	Enable to Output								Figures 1, 2	
t _{TLH}	Transition Time	0.30	1.20	0.30	1.20	0.30	1.20			(Note 10)
t _{THL}	20% to 80%, 80% to 20%							ns		

Note 7: F100K 300 Series cold temperature testing is performed by temperature soaking (to guarantee junction temperature equals –55°C), then testing immediately after power-up. This provides "cold start" specs which can be considered a worst case condition at cold temperatures.

AC Electrical Characteristics (Continued)

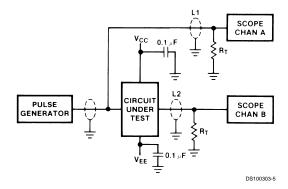
Note 8: Screen tested 100% on each device at +25°C temperature only, Subgroup A9.

Note 9: Sample tested (Method 5005, Table I) on each manufactured lot at +25°C, Subgroup A9, and at +125°C and -55°C temperatures, Subgroups A10 and A11.

Note 10: Not tested at +25°C, +125°C, and -55°C temperature (design characterization data).

Note 11: The propagation delay specified is for single output switching. Delays may vary up to 100 ps with multiple outputs switching.

Test Circuitry



Notes:

V_{CC}, V_{CCA} = +2V, V_{EE} = -2.5V L1 and L2 = equal length 50Ω impedance lines R_T = 50Ω terminator internal to scope Decoupling 0.1 μF from GND to V_{CC} and V_{EE} All unused outputs are loaded with 50Ω to GND C_L = Fixture and stray capacitance ≤ 3 pF

FIGURE 1. AC Test Circuit

Switching Waveforms

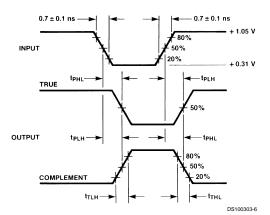
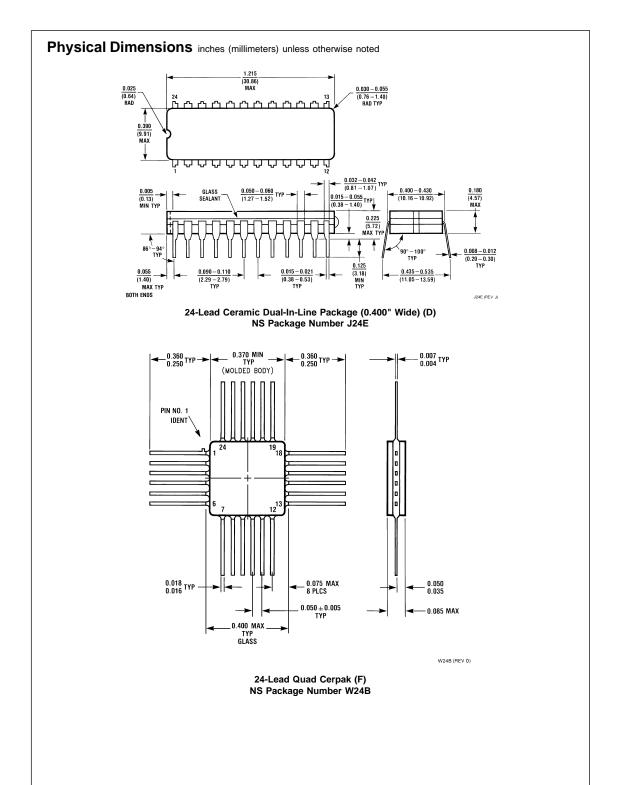


FIGURE 2. Propagation Delay and Transition Times

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Datasheet

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Package Availability, Models, Samples & Pricing

Dout Nameh	Package		Status	Models		Samples &	Budgetary Pricing		Std	Package
Part Number	Type	# pins	Status	SPICE	IBIS	Electronic Orders	Quantity	\$US each	Pack Size	Marking
5962-9152802MXA	Cerdip	24	Full production	N/A	N/A	X	50+	\$20.4000	tube of 15	[logo]¢Z¢S¢4¢A\$E 100302DMQB/Q 5962-9152802MXA
5962-9152802MYA	Cerquad	24	Full production	N/A	N/A	· ×	50+	\$20.4000	tube of 14	[logo]¢Z¢S¢4¢A Q\$E 100302 FMQB 5962 -9152802 MYA
5962-9152802VXA	Cerdip	24	Full production	N/A	N/A		50+	\$265.0000	1	[logo]¢Z¢S¢4¢A\$E 100302J-QMLV 5962-9152802VXA
5962-9152802VYA	Cerquad	24	Full production	N/A	N/A		50+	\$245.0000	tube of 14	[logo]¢Z¢S¢4¢A 100302W- QMLV 5962 -9152802 VYA \$E
100302 MW8	waf	er	Full production	N/A	N/A				N/A	-

[Information as of 1-Sep-2000]

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